

最终数据表

英飞凌CoolSiC™ 1200 V SiC 沟道MOSFET

特性

- $T_{vj} = -55\sim 175^{\circ}\text{C}$ 时 $V_{DS} = 1200\text{ V}$
- $T_C = 25^{\circ}\text{C}$ 时 $I_{DDC} = 202\text{ A}$
- $R_{DS(on)} = 8.7\text{ m}\Omega$ ($V_{GS} = 20\text{ V}$ 、 $T_{vj} = 25^{\circ}\text{C}$ 时)
- 新的性能优化芯片技术 (Gen1p)，改善了 $R_{DS(on)}$ * AFOM
- 提高了建议开启电压 ($V_{GS(on)} = 20\text{ V}$) 以降低 $R_{DS(on)}$
- 业界领先的开关能量特性，可降低开关损耗并减少冷却需求
- 最低的器件电容值，可实现更高的开关速度和更高的功率密度
- 低 C_{rss}/C_{iss} 电容比值和高 $V_{GS(th)}$ 的组合，可避免寄生导通并实现单极性栅极驱动
- 降低了总栅极电荷 Q_G ，可降低驱动功率和损耗
- .XT 芯片粘接技术，实现业界领先的热性能
- 用于优化开关性能的检测引脚
- 适合高压爬电要求

潜在应用

- 车载充电器
- 直流/直流转换器
- 辅助驱动

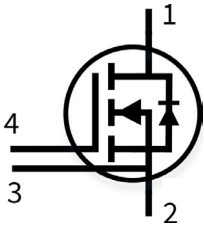
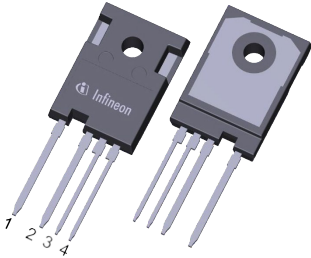
产品验证

- 适合汽车应用。根据 AEC-Q100/101 进行产品验证

描述

引脚定义：

- 1 - 漏极
- 2 - 来源
- 3 - 开尔文检测
- 4 - 栅极



Type	Package	Marking
AIMZH120R010M1T	PG-TO247-4-STD-NT6.7	A12M1T010

本数据手册的原文使用英文撰写。为方便起见，英飞凌提供了译文；由于翻译过程中可能使用了自动化工具，英飞凌不保证译文的准确性。为确认准确性，请务必访问 infineon.com 参考最新的英文版本（控制文档）。



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1 封装

1 封装

表1 特征值

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Storage temperature	T_{stg}		-55		150	°C
Soldering temperature	T_{sold}				260	°C
MOSFET/body diode thermal resistance, junction-case	$R_{\text{th(j-c)}}$			0.15	0.19	K/W

注释：无需经过生产测试 - 经过设计/特性验证

2 MOSFET

表2 最大额定值

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V_{DSS}	$T_{\text{vj}} = -55 \dots 175 \text{ °C}$		1200	V
Continuous DC drain current for $R_{\text{th(j-c,max)}}$, limited by $T_{\text{vj(max)}}$	I_{DDC}	$V_{\text{GS}} = 20 \text{ V}$	$T_{\text{c}} = 25 \text{ °C}$	202	A
			$T_{\text{c}} = 100 \text{ °C}$	146	
Peak drain current, t_{p} limited by $T_{\text{vj(max)}}$	I_{DM}	$V_{\text{GS}} = 20 \text{ V}$		526	A
Gate-source voltage, max. transient voltage ¹⁾	V_{GS}	$t_{\text{p}} \leq 0.5 \text{ }\mu\text{s}, D < 0.01$		-10...25	V
Gate-source voltage, max. static voltage	V_{GS}			-5...23	V
Avalanche energy, single pulse	E_{AS}	$I_{\text{D}} = 70 \text{ A}, V_{\text{DD}} = 50 \text{ V}, L = 0.26 \text{ mH}$		625	mJ
Power dissipation, limited by $T_{\text{vj(max)}}$	P_{tot}		$T_{\text{c}} = 25 \text{ °C}$	750	W
			$T_{\text{c}} = 100 \text{ °C}$	375	

1) **重要注释：**正负栅极源电压的选择会影响器件的长期行为。为了确保器件在计划使用寿命内的正常运行，必须考虑应用说明AN2018-09中描述的设计指南。

表 3 建议值

Parameter	Symbol	Note or test condition	Values	Unit
Recommended turn-on gate voltage	$V_{\text{GS(on)}}$		20	V
Recommended turn-off gate voltage	$V_{\text{GS(off)}}$		0	V

表4 特征值

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Drain-source on-state resistance	$R_{DS(on)}$	$I_D = 93\text{ A}$	$T_{vj} = 25\text{ °C}$, $V_{GS(on)} = 20\text{ V}$		8.7	11.3	mΩ
			$T_{vj} = 100\text{ °C}$, $V_{GS(on)} = 20\text{ V}$		12.2		
			$T_{vj} = 175\text{ °C}$, $V_{GS(on)} = 20\text{ V}$		17.3		
			$T_{vj} = 25\text{ °C}$, $V_{GS(on)} = 18\text{ V}$		9.5		
Gate-source threshold voltage	$V_{GS(th)}$	$I_D = 30\text{ mA}$, $V_{DS} = V_{GS}$ (tested after 1 ms pulse at $V_{GS} = 20\text{ V}$)	$T_{vj} = 25\text{ °C}$	3.5	4.3	5.1	V
			$T_{vj} = 175\text{ °C}$		3.8		
Zero gate-voltage drain current	I_{DSS}	$V_{DS} = 1200\text{ V}$, $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		1	90	μA
			$T_{vj} = 175\text{ °C}$		50		
Gate leakage current	I_{GSS}	$V_{DS} = 0\text{ V}$	$V_{GS} = 25\text{ V}$			100	nA
			$V_{GS} = -10\text{ V}$			-100	
Forward transconductance	g_{fs}	$I_D = 93\text{ A}$, $V_{DS} = 20\text{ V}$			59		S
Short-circuit withstand time ¹⁾	t_{SC}	$V_{DD} \leq 800\text{ V}$, $V_{DS,peak} < 1200\text{ V}$, $T_{vj(start)} = 25\text{ °C}$, $R_{G,ext} = 2\text{ }\Omega$	$V_{GS(on)} = 20\text{ V}$		1.5		μs
			$V_{GS(on)} = 18\text{ V}$		2		
			$V_{GS(on)} = 15\text{ V}$		2.5		
Internal gate resistance	$R_{G,int}$	$f = 1\text{ MHz}$, $V_{AC} = 25\text{ mV}$			2.4		Ω
Input capacitance	C_{iss}	$V_{DD} = 800\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 100\text{ kHz}$, $V_{AC} = 25\text{ mV}$			5703		pF
Output capacitance	C_{oss}	$V_{DD} = 800\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 100\text{ kHz}$, $V_{AC} = 25\text{ mV}$			268		pF
Reverse transfer capacitance	C_{rss}	$V_{DD} = 800\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 100\text{ kHz}$, $V_{AC} = 25\text{ mV}$			16		pF
C_{oss} stored energy	E_{oss}	$V_{DD} = 800\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 100\text{ kHz}$, $V_{AC} = 25\text{ mV}$			107		μJ
Total gate charge	Q_G	$V_{DD} = 800\text{ V}$, $I_D = 93\text{ A}$, $V_{GS} = 0/20\text{ V}$, turn-on pulse			178		nC
Plateau gate charge	$Q_{GS(pl)}$	$V_{DD} = 800\text{ V}$, $I_D = 93\text{ A}$, $V_{GS} = 0/20\text{ V}$, turn-on pulse			44		nC
Gate-to-drain charge	Q_{GD}	$V_{DD} = 800\text{ V}$, $I_D = 93\text{ A}$, $V_{GS} = 0/20\text{ V}$, turn-on pulse			30		nC
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 800\text{ V}$, $I_D = 93\text{ A}$, $V_{GS} = 0/20\text{ V}$, $R_{GS(on)} = 2\text{ }\Omega$, $R_{GS(off)} = 2\text{ }\Omega$, $L_\sigma = 15\text{ nH}$	$T_{vj} = 25\text{ °C}$		21		ns
			$T_{vj} = 175\text{ °C}$		21		

(表格续下页.....)

表 4（续） 特征值

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Rise time	t_r	$V_{DD} = 800\text{ V}, I_D = 93\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH}$	$T_{vj} = 25\text{ }^\circ\text{C}$		20		ns
			$T_{vj} = 175\text{ }^\circ\text{C}$		29		
Turn-off delay time	$t_{d(off)}$	$V_{DD} = 800\text{ V}, I_D = 93\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH}$	$T_{vj} = 25\text{ }^\circ\text{C}$		53		ns
			$T_{vj} = 175\text{ }^\circ\text{C}$		64		
Fall time	t_f	$V_{DD} = 800\text{ V}, I_D = 93\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH}$	$T_{vj} = 25\text{ }^\circ\text{C}$		13		ns
			$T_{vj} = 175\text{ }^\circ\text{C}$		16		
Turn-on energy	E_{on}	$V_{DD} = 800\text{ V}, I_D = 93\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH}$	$T_{vj} = 25\text{ }^\circ\text{C}$		736		μJ
			$T_{vj} = 175\text{ }^\circ\text{C}$		1327		
Turn-off energy	E_{off}	$V_{DD} = 800\text{ V}, I_D = 93\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH}$	$T_{vj} = 25\text{ }^\circ\text{C}$		833		μJ
			$T_{vj} = 175\text{ }^\circ\text{C}$		1091		
Total switching energy	E_{tot}	$V_{DD} = 800\text{ V}, I_D = 93\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH}$	$T_{vj} = 25\text{ }^\circ\text{C}$		1569		μJ
			$T_{vj} = 175\text{ }^\circ\text{C}$		2418		
Virtual junction temperature	T_{vj}			-55		175	$^\circ\text{C}$

1)通过设计/特性验证

注释： 动态测试电路见图F。

3 体二极管（MOSFET）

表5 最大额定值

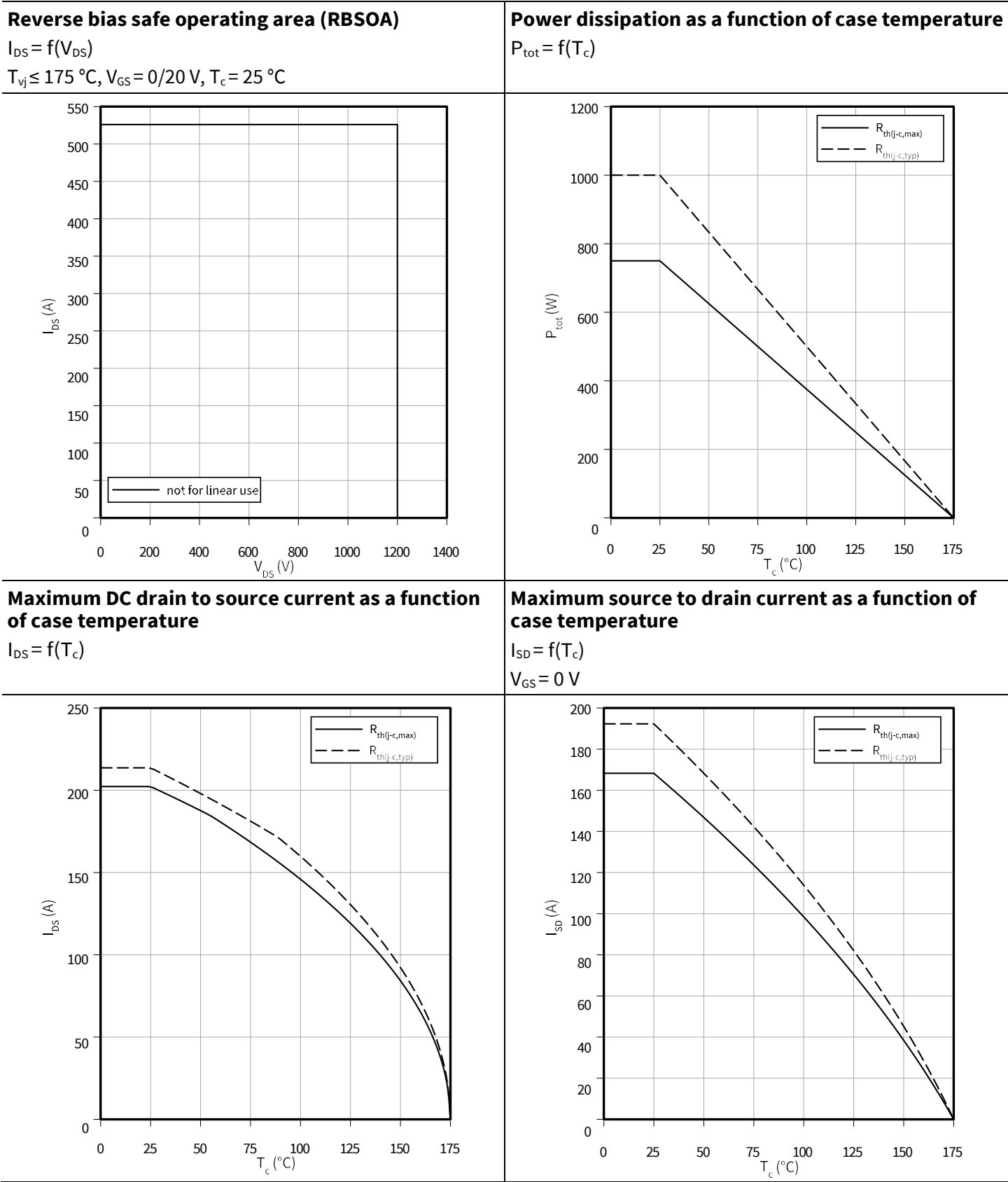
Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V_{DSS}	$T_{vj} = -55...175\text{ }^\circ\text{C}$		1200	V
Continuous reverse drain current for $R_{th(j-c,max)}$, limited by $T_{vj(max)}$	I_{SDC}	$V_{GS} = 0\text{ V}$	$T_c = 25\text{ }^\circ\text{C}$	168	A
			$T_c = 100\text{ }^\circ\text{C}$	98	
Peak reverse drain current, t_p limited by $T_{vj(max)}$	I_{SM}	$V_{GS} = 0\text{ V}$		208	A



表6 特征值

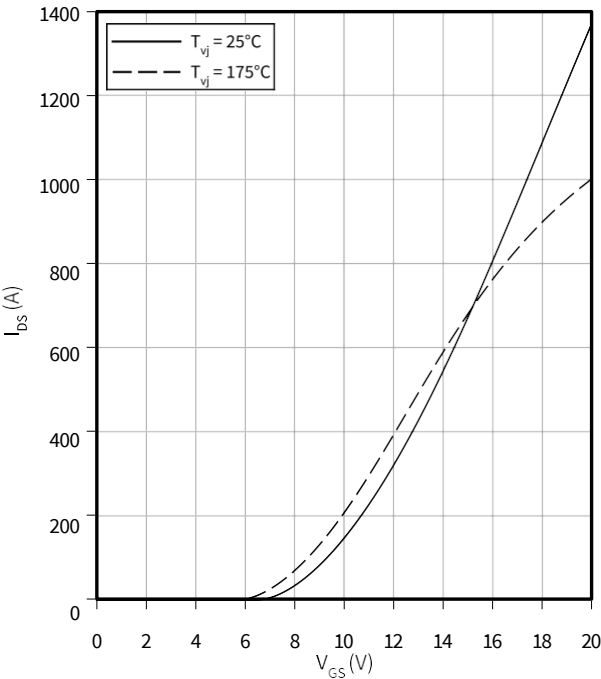
Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Drain-source reverse voltage	V_{SD}	$I_{SD} = 93\text{ A}$, $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		3.9	5	V
			$T_{vj} = 100\text{ °C}$		3.8		
			$T_{vj} = 175\text{ °C}$		3.7		
MOSFET forward recovery charge	Q_{fr}	$V_{DD} = 800\text{ V}$, $I_{SD} = 93\text{ A}$, $V_{GS} = 0\text{ V}$, $di_{SD}/dt = 3000\text{ A}/\mu\text{s}$, Q_{fr} includes also Q_C	$T_{vj} = 25\text{ °C}$		570		nC
			$T_{vj} = 175\text{ °C}$		1650		
MOSFET peak forward recovery current	I_{frm}	$V_{DD} = 800\text{ V}$, $I_{SD} = 93\text{ A}$, $V_{GS} = 0\text{ V}$, $di_{SD}/dt = 3000\text{ A}/\mu\text{s}$, Q_{fr} includes also Q_C	$T_{vj} = 25\text{ °C}$		18		A
			$T_{vj} = 175\text{ °C}$		42		
Virtual junction temperature	T_{vj}			-55		175	°C

4 特性图



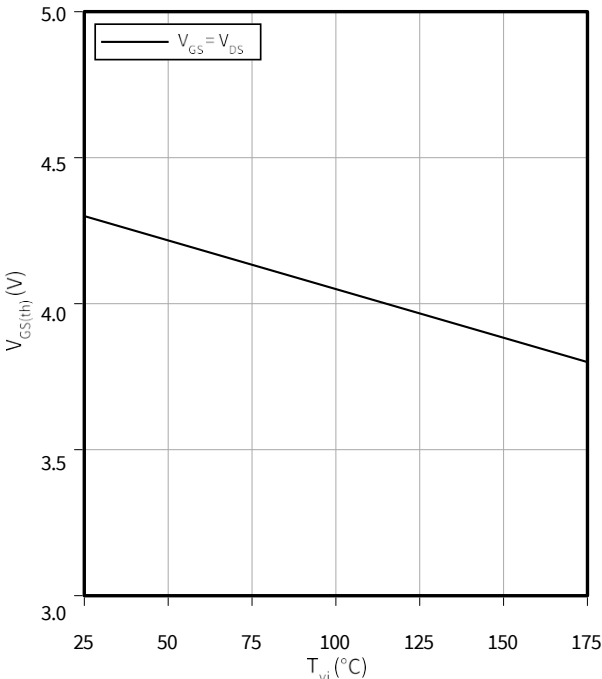
Typical transfer characteristic

$I_{DS} = f(V_{GS})$
 $V_{DS} = 20\text{ V}$



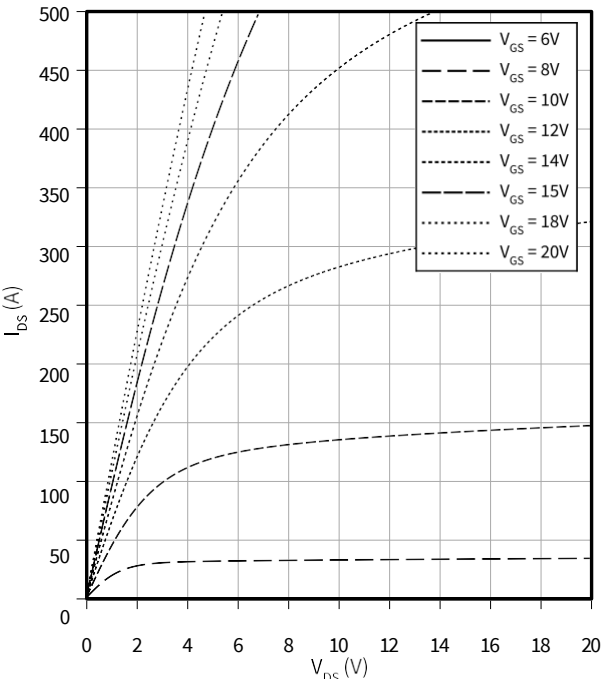
Typical gate-source threshold voltage as a function of junction temperature

$V_{GS(th)} = f(T_{vj})$
 $I_D = 30\text{ mA}$



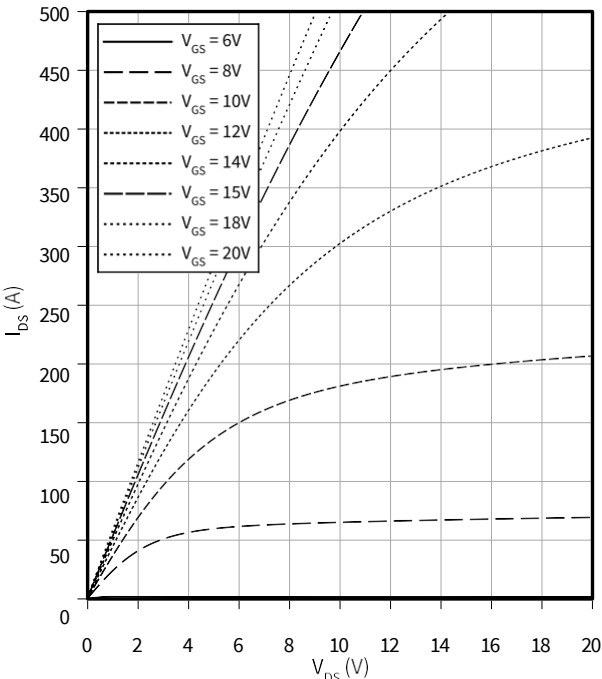
Typical output characteristic, V_{GS} as parameter

$I_{DS} = f(V_{DS})$
 $T_{vj} = 25\text{ °C}$



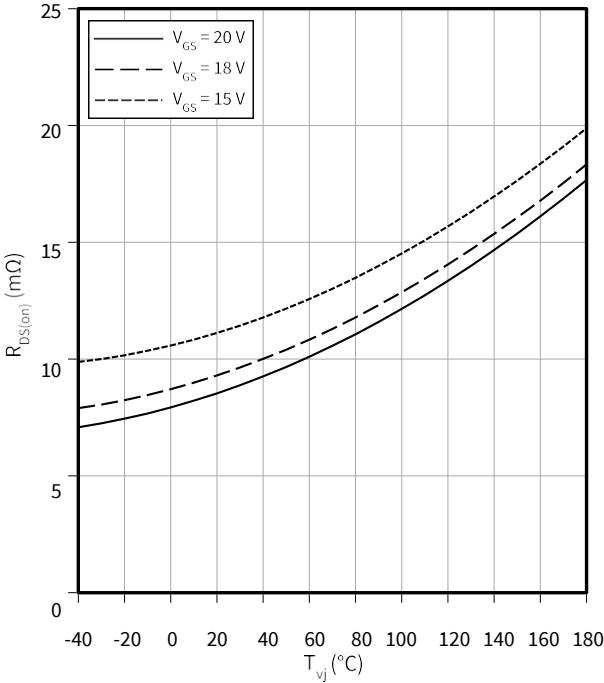
Typical output characteristic, V_{GS} as parameter

$I_{DS} = f(V_{DS})$
 $T_{vj} = 175\text{ °C}$



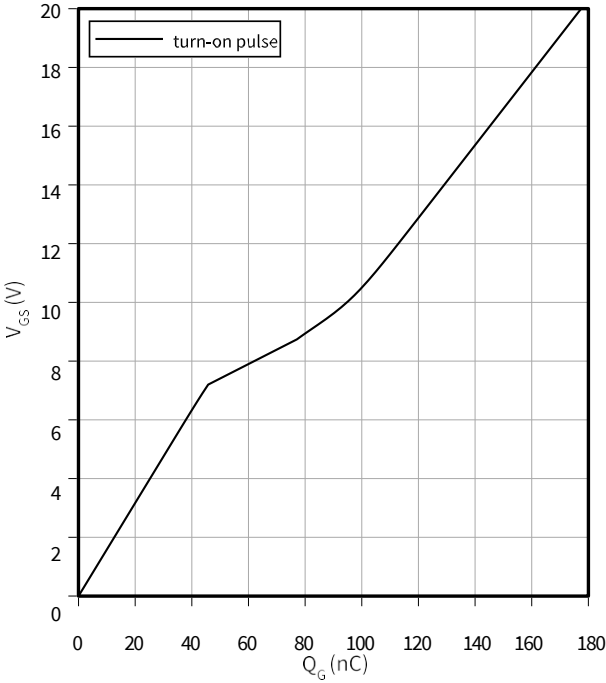
Typical on-state resistance as a function of junction temperature

$R_{DS(on)} = f(T_{vj})$
 $I_D = 93\text{ A}$



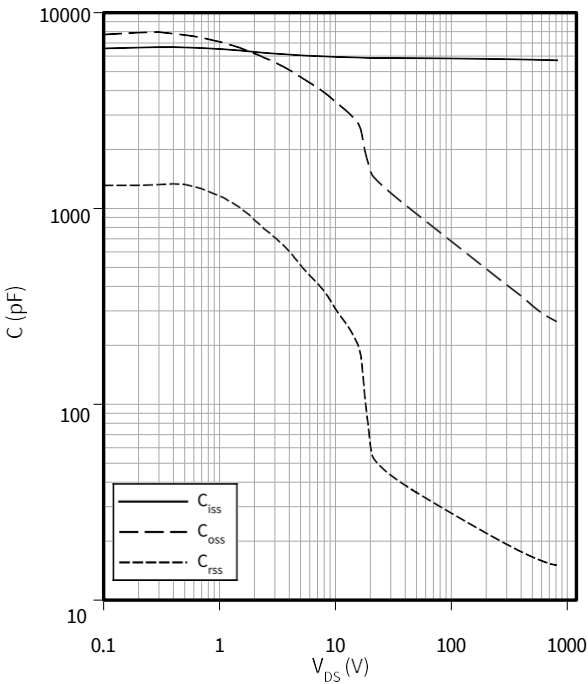
Typical gate charge

$V_{GS} = f(Q_G)$
 $I_D = 93\text{ A}, V_{DS} = 800\text{ V}$



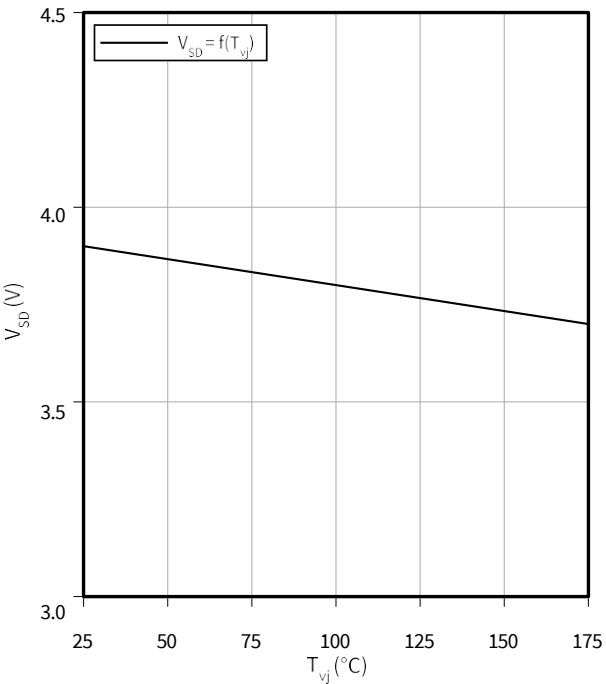
Typical capacitance as a function of drain-source voltage

$C = f(V_{DS})$
 $f = 100\text{ kHz}, V_{GS} = 0\text{ V}$



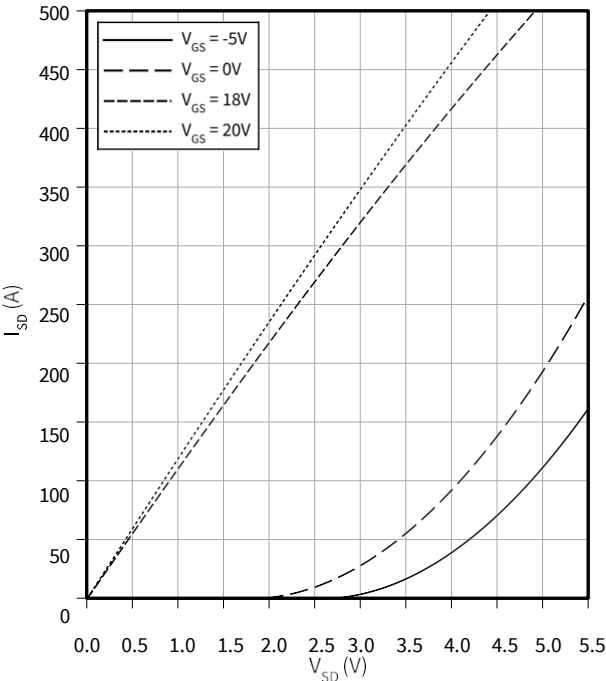
Typical reverse drain voltage as function of junction temperature

$V_{SD} = f(T_{vj})$
 $I_{SD} = 93\text{ A}, V_{GS} = 0\text{ V}$



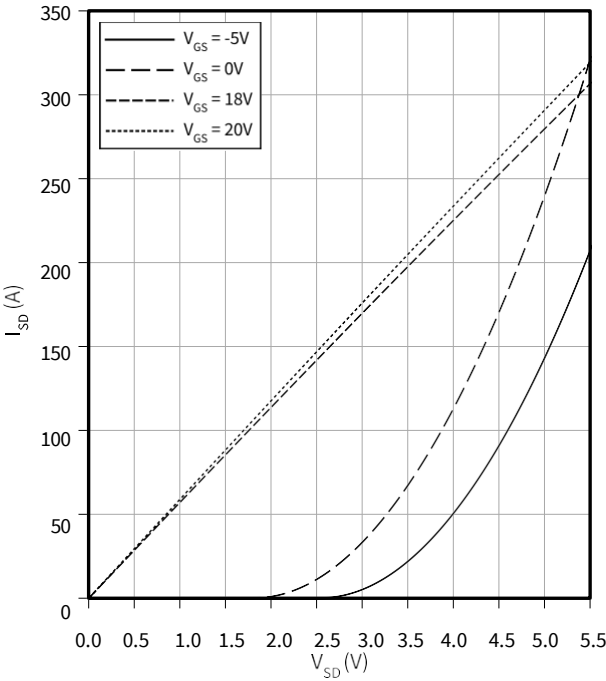
Typical reverse drain current as function of reverse drain voltage, V_{GS} as parameter

$I_{SD} = f(V_{SD})$
 $T_{vj} = 25\text{ }^{\circ}\text{C}$



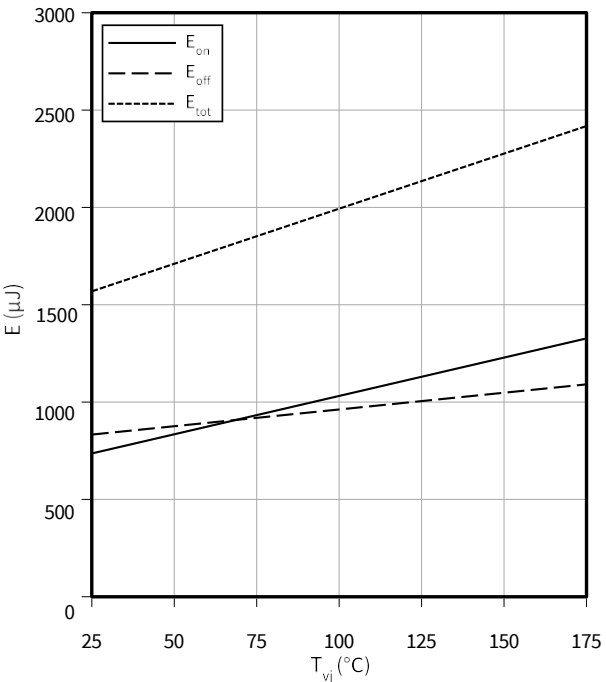
Typical reverse drain current as function of reverse drain voltage, V_{GS} as parameter

$I_{SD} = f(V_{SD})$
 $T_{vj} = 175\text{ }^{\circ}\text{C}$



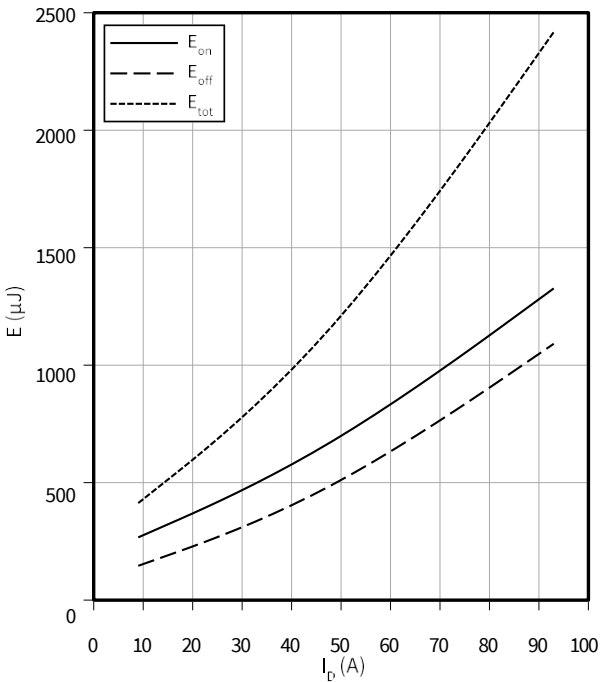
Typical switching energy as a function of junction temperature, test circuit in Fig. F, 2nd device own body diode: $V_{GS} = 0\text{ V}$

$E = f(T_{vj})$
 $V_{GS} = 0/20\text{ V}$, $I_D = 93\text{ A}$, $R_{G,ext} = 2\text{ }\Omega$, $V_{DD} = 800\text{ V}$



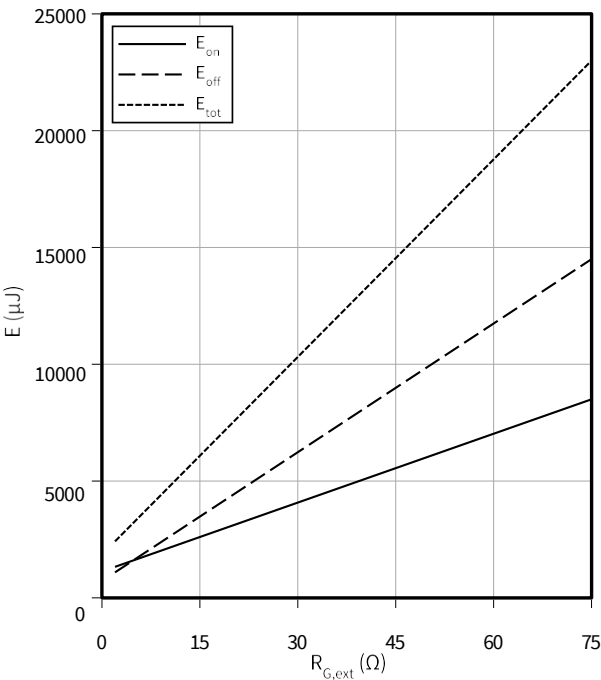
Typical switching energy as a function of drain current, test circuit in Fig. F, 2nd device own body diode: $V_{GS} = 0\text{ V}$

$E = f(I_D)$
 $V_{GS} = 0/20\text{ V}$, $T_{vj} = 175\text{ }^{\circ}\text{C}$, $R_{G,ext} = 2\text{ }\Omega$, $V_{DD} = 800\text{ V}$



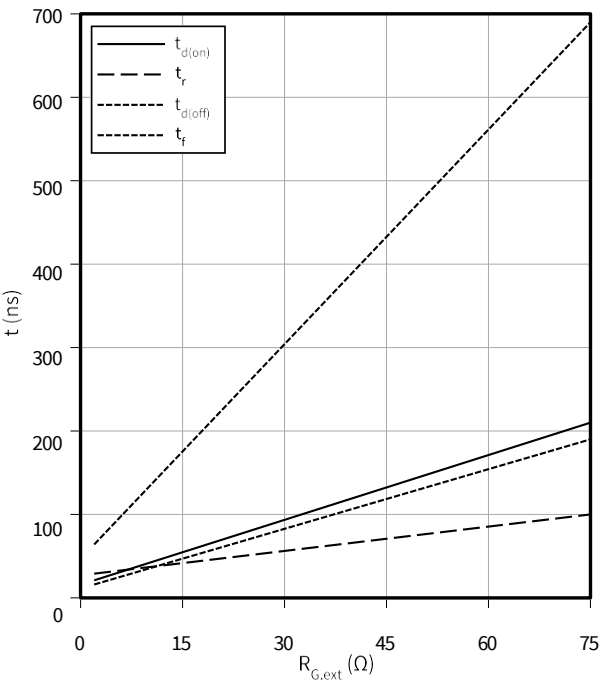
Typical switching energy as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode: $V_{GS} = 0\text{ V}$

$E = f(R_{G,ext})$
 $V_{GS} = 0/20\text{ V}$, $I_D = 93\text{ A}$, $T_{vj} = 175\text{ }^{\circ}\text{C}$, $V_{DD} = 800\text{ V}$



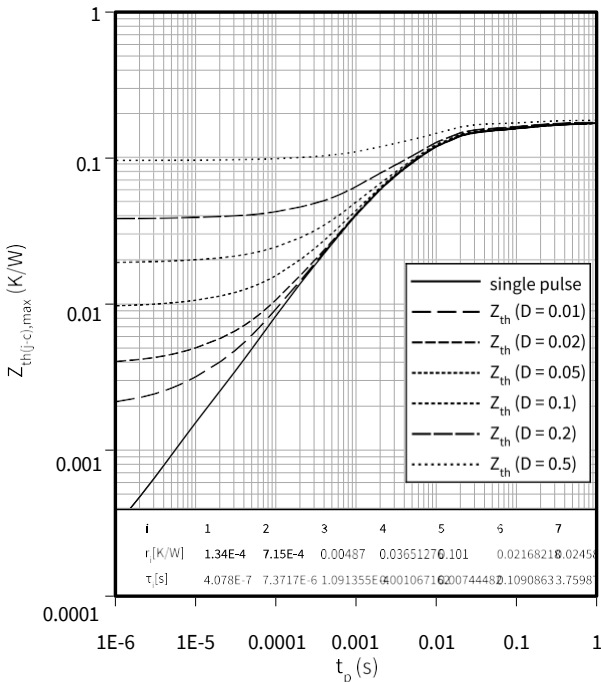
Typical switching times as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode: $V_{GS} = 0\text{ V}$

$t = f(R_{G,ext})$
 $V_{DD} = 800\text{ V}$, $V_{GS} = 0/20\text{ V}$, $I_D = 93\text{ A}$, $T_{vj} = 175\text{ }^{\circ}\text{C}$

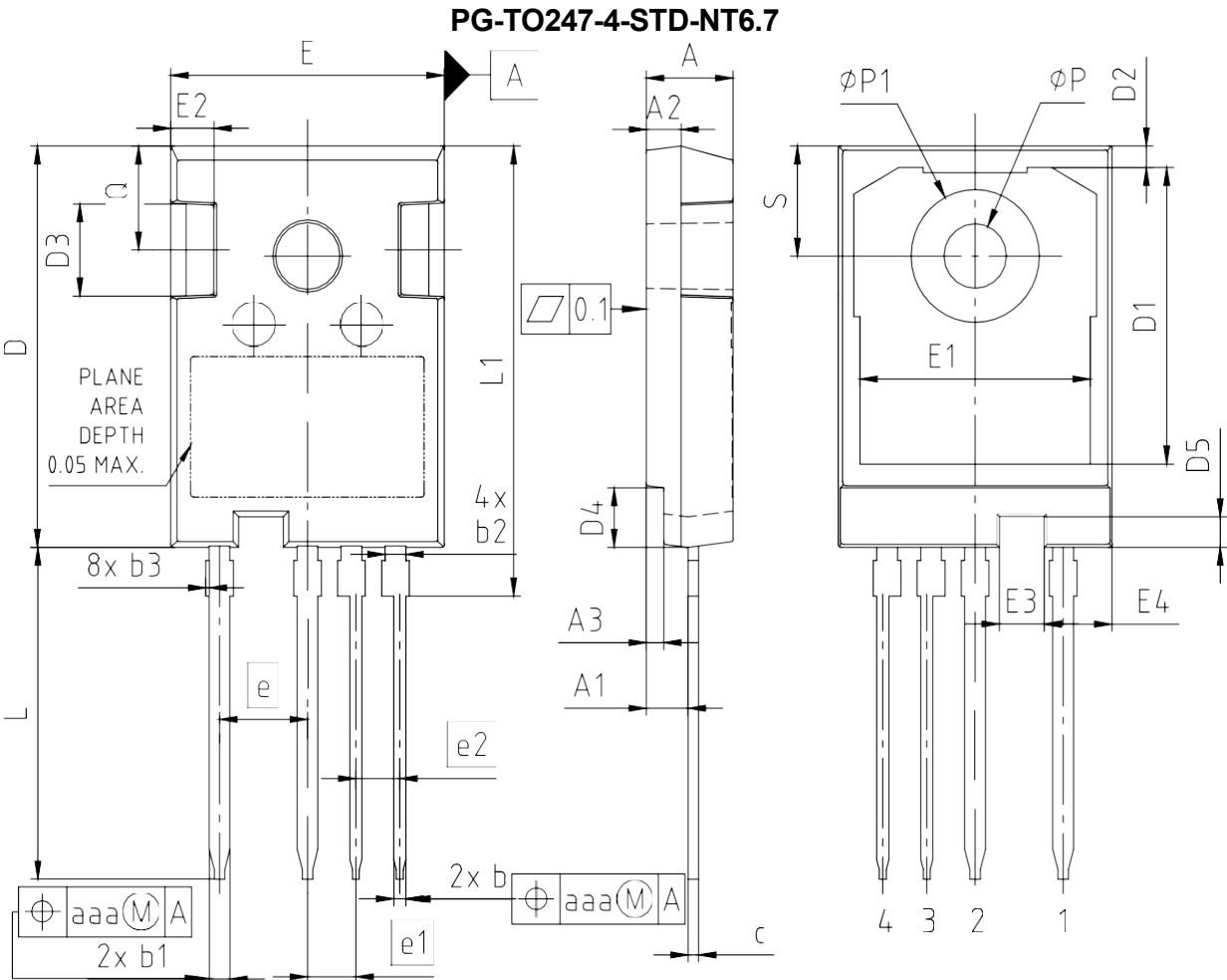


Max. transient thermal impedance (MOSFET/diode)

$Z_{th(j-c),max} = f(t_p)$
 $D = t_p/T$



5 封装外形



PACKAGE - GROUP NUMBER: PG-TO247-4-U03					
DIMENSIONS	MILLIMETERS		DIMENSIONS	MILLIMETERS	
	MIN.	MAX.		MIN.	MAX.
A	4.90	5.10	E	15.70	15.90
A1	2.31	2.51	E1	13.10	13.50
A2	1.90	2.10	E2	2.40	2.60
A3	0.90	1.10	E3	2.48	2.68
b	0.66	0.79	E4	3.82	4.02
b1	1.16	1.29	e	5.08	
b2	1.16	1.29	e1	2.79	
b3		0.20	e2	2.54	
c	0.59	0.66	N	4	
D	22.30	22.50	L	18.40	18.70
D1	16.25	16.85	L1	24.97	25.27
D2	1.05	1.35	øP	3.50	3.70
D3	5.00	5.20	øP1		7.40
D4	3.22	3.42	Q	5.60	6.00
D5	1.60	1.80	S	6.00	6.30
			aaa	0.25	

NOTE: DIMENSIONS DO NOT INCLUDE MOLDFLASH; PROTRUSION OR GARE BURRS

图 1

6 测试条件

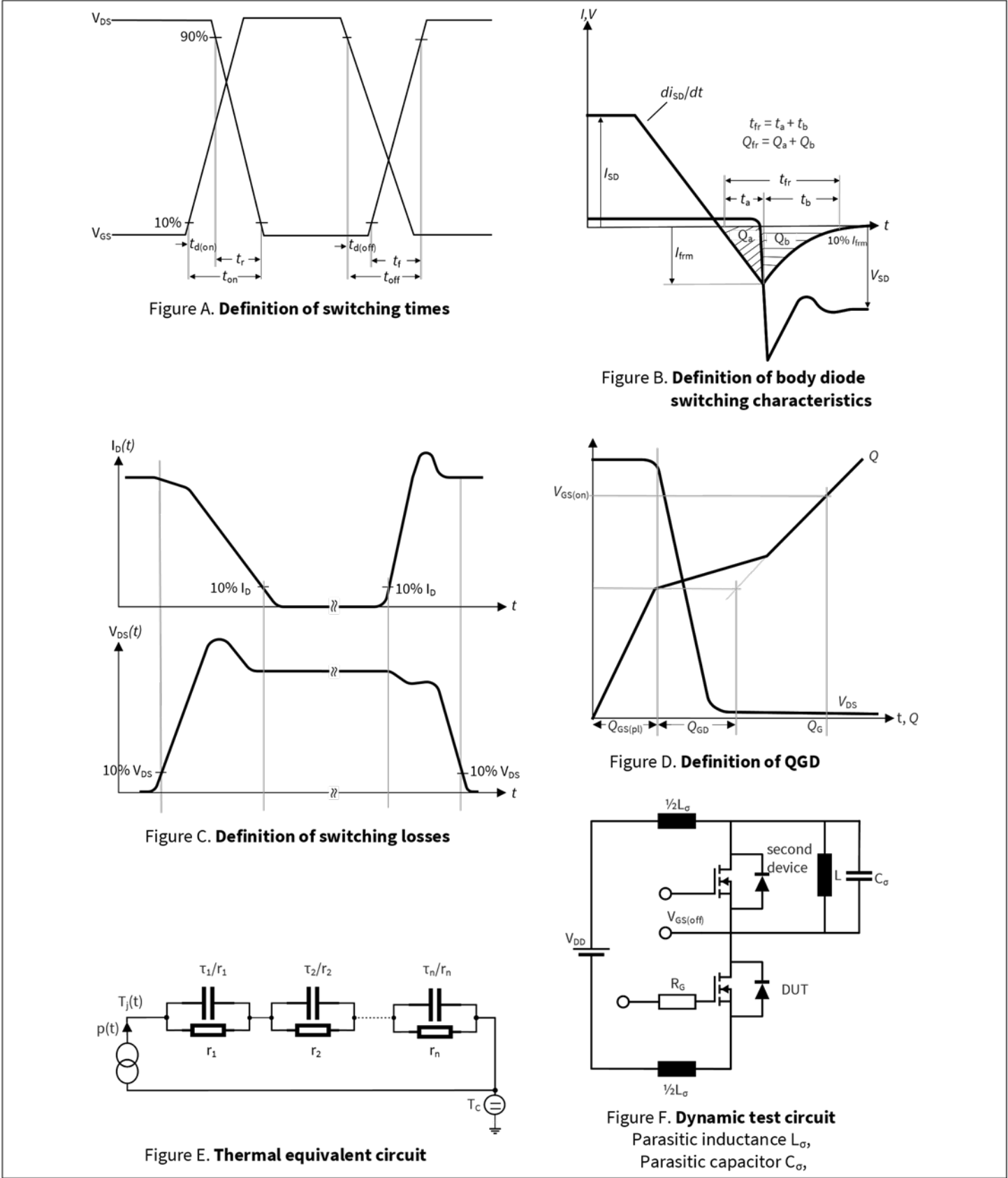


图 2



修订记录

修订记录

Document revision	Date of release	Description of changes
0.10	2022-04-19	Target datasheet
0.20	2023-07-31	Preliminary datasheet
0.30	2023-08-03	Correction of inductance unit (p. 3)
1.00	2023-11-29	Final datasheet



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